

Applicati n No.	Applicant(s)	- <u>-</u>
09/896,507	GIBSON ET AL.	
Examiner	Art Unit	
Jude J Jean-Gilles	2143	

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SEARCHED					
Class	Subclass	Date	Examiner		
709	238 223 205	12/16/2004	JG		
711	111 112 170	12/16/2004	JG		
370	241	12/16/2004	JG		
714	4-6 8	12/16/2004	JG		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PAM tool: Duble Patenting Effective Filing Date Inventor/Assignee Foreign Priority Date	12/16/2004	JG		
ESAT tool: USPAT EPA JPO DERWENT	12/16/2004	JG		
Internet : Google.coom onelok.com NPL IEEE ACM	12/16/2004	JG		
Primary consulted: William Vaugh: Double Patenting Scott Bederman: Previous examination on app #: 09/896,662	12/16/2004	JG		
Terms definition: Microsoft Computer Dictionary(fifth edition) American College Dictionary (fourth edition)	12/16/2004	JG		
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